

# FDMA3027PZ

## Dual P-Channel PowerTrench® MOSFET

-30 V, -3.3 A, 87 mΩ

### Features

- Max  $r_{DS(on)}$  = 87 mΩ at  $V_{GS} = -10$  V,  $I_D = -3.3$  A
- Max  $r_{DS(on)}$  = 152 mΩ at  $V_{GS} = -4.5$  V,  $I_D = -2.3$  A
- HBM ESD protection level > 2 KV typical (Note 3)
- Low profile - 0.8 mm maximum - in the new package MicroFET 2x2 mm
- RoHS Compliant

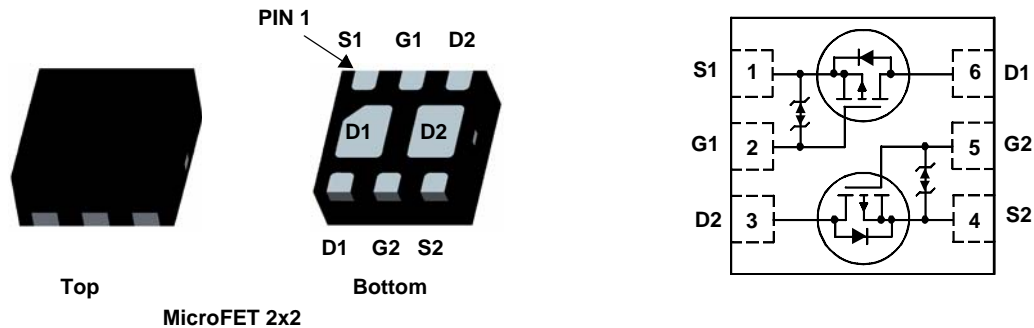


### General Description

This device is designed specifically as a single package solution for dual switching requirements such as gate driver for larger Mosfets. It features two independent P-Channel MOSFETs with low on-state resistance for minimum conduction losses. The MicroFET 2x2 package offers exceptional thermal performance for its physical size and is well suited to linear mode applications. G-S zener has been added to enhance ESD voltage level.

### Applications

- Load Switch
- Discrete Gate Driver



### MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain to Source Voltage	-30	V
$V_{GS}$	Gate to Source Voltage	±25	V
$I_D$	Drain Current -Continuous (Note 1a)	-3.3	A
	-Pulsed	-15	
$P_D$	Power Dissipation (Note 1a)	1.4	W
	Power Dissipation (Note 1b)	0.7	
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	°C

### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance for Single Operation, Junction to Ambient (Note 1a)	86	°C/W
	Thermal Resistance for Single Operation, Junction to Ambient (Note 1b)	173	
	Thermal Resistance for Dual Operation, Junction to Ambient (Note 1c)	69	
	Thermal Resistance for Dual Operation, Junction to Ambient (Note 1d)	151	
	Thermal Resistance for Single Operation, Junction to Ambient (Note 1e)	160	
	Thermal Resistance for Dual Operation, Junction to Ambient (Note 1f)	133	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
327	FDMA3027PZ	MicroFET 2X2	7"	8 mm	3000 units

**Electrical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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**Off Characteristics**

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = -250\ \mu\text{A}, V_{GS} = 0\ \text{V}$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		-22		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -24\ \text{V}, V_{GS} = 0\ \text{V}$			-1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 25\ \text{V}, V_{DS} = 0\ \text{V}$			$\pm 10$	$\mu\text{A}$

**On Characteristics**

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250\ \mu\text{A}$	-1	-1.9	-3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		5		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = -10\ \text{V}, I_D = -3.3\ \text{A}$		69	87	m $\Omega$
		$V_{GS} = -4.5\ \text{V}, I_D = -2.3\ \text{A}$		108	152	
		$V_{GS} = -10\ \text{V}, I_D = -3.3\ \text{A}, T_J = 125\text{ }^\circ\text{C}$		97	122	
$g_{FS}$	Forward Transconductance	$V_{DS} = -5\ \text{V}, I_D = -3.3\ \text{A}$		6		S

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	$V_{DS} = -15\ \text{V}, V_{GS} = 0\ \text{V},$ $f = 1\ \text{MHz}$		324	435	pF
$C_{oss}$	Output Capacitance			59	80	pF
$C_{rss}$	Reverse Transfer Capacitance			53	80	pF
$R_g$	Gate Resistance			12		$\Omega$

**Switching Characteristics**

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -15\ \text{V}, I_D = -3.3\ \text{A},$ $V_{GS} = -10\ \text{V}, R_{GEN} = 6\ \Omega$		5.2	11	ns
$t_r$	Rise Time			3	10	ns
$t_{d(off)}$	Turn-Off Delay Time			17	31	ns
$t_f$	Fall Time			11	25	ns
$Q_{g(TOT)}$	Total Gate Charge		$V_{GS} = 0\ \text{V to } -10\ \text{V}$	$V_{DD} = -15\ \text{V},$ $I_D = -3.3\ \text{A}$	7.2	10
	Total Gate Charge	$V_{GS} = 0\ \text{V to } -5\ \text{V}$	4.1		6	nC
$Q_{gs}$	Gate to Source Charge		1.0			nC
$Q_{gd}$	Gate to Drain "Miller" Charge		1.9			nC

**Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\ \text{V}, I_S = -3.3\ \text{A}$ (Note 2)		-0.94	-1.3	V
$t_{rr}$	Reverse Recovery Time	$I_F = -3.3\ \text{A}, di/dt = 100\ \text{A}/\mu\text{s}$		20	32	ns
$Q_{rr}$	Reverse Recovery Charge			10	18	nC

## Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

### Notes:

1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.

- (a)  $R_{\theta JA} = 86\text{ }^\circ\text{C/W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB. For single operation.
- (b)  $R_{\theta JA} = 173\text{ }^\circ\text{C/W}$  when mounted on a minimum pad of 2 oz copper. For single operation.
- (c)  $R_{\theta JA} = 69\text{ }^\circ\text{C/W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB. For dual operation.
- (d)  $R_{\theta JA} = 151\text{ }^\circ\text{C/W}$  when mounted on a minimum pad of 2 oz copper. For dual operation.
- (e)  $R_{\theta JA} = 160\text{ }^\circ\text{C/W}$  when mounted on a 30 mm<sup>2</sup> pad of 2 oz copper. For single operation.
- (f)  $R_{\theta JA} = 133\text{ }^\circ\text{C/W}$  when mounted on a 30 mm<sup>2</sup> pad of 2 oz copper. For dual operation.



a. 86 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



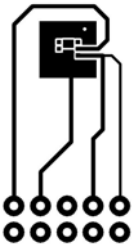
b. 173 °C/W when mounted on a minimum pad of 2 oz copper



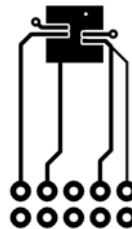
c. 69 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



d. 151 °C/W when mounted on a minimum pad of 2 oz copper



e. 160 °C/W when mounted on 30 mm<sup>2</sup> pad of 2 oz copper

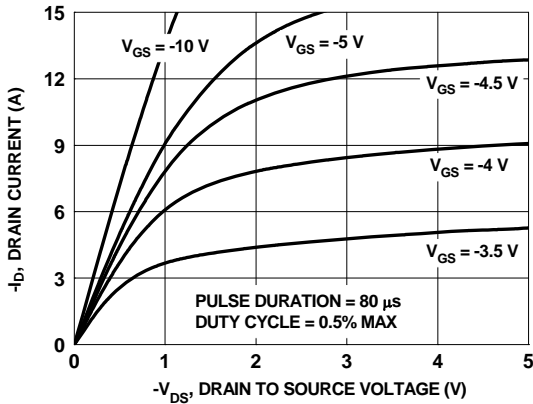


f. 133 °C/W when mounted on 30 mm<sup>2</sup> pad of 2 oz copper

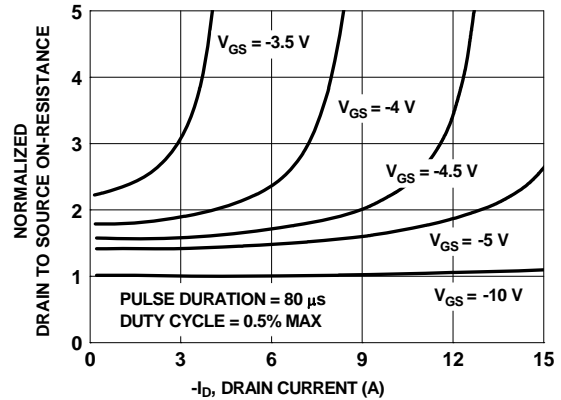
2. Pulse Test : Pulse Width < 300 us, Duty Cycle < 2.0%

3. The diode connected between gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

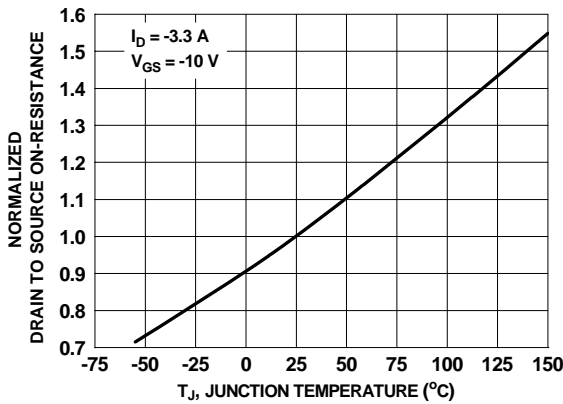
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



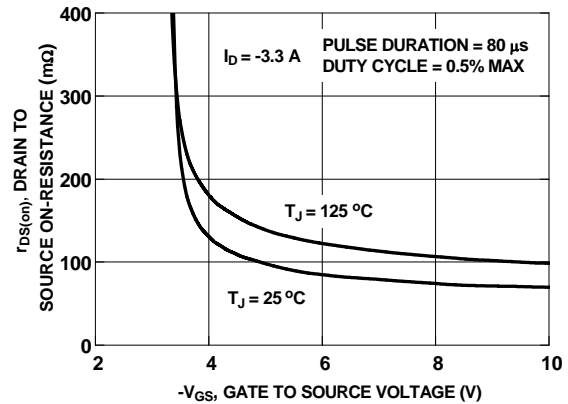
**Figure 1. On-Region Characteristics**



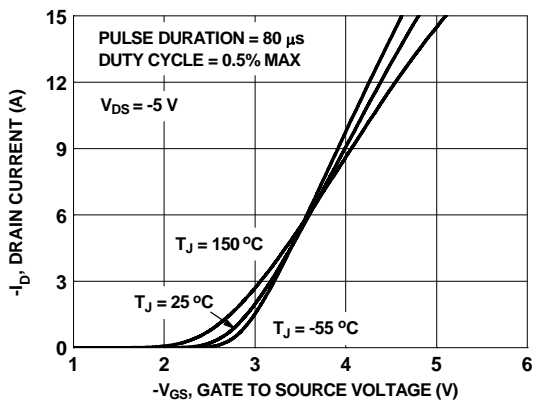
**Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage**



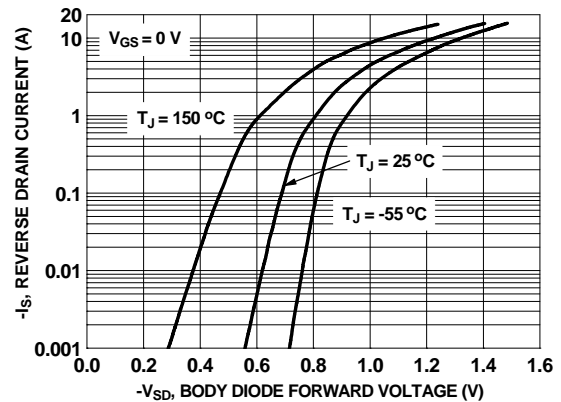
**Figure 3. Normalized On-Resistance vs Junction Temperature**



**Figure 4. On-Resistance vs Gate to Source Voltage**

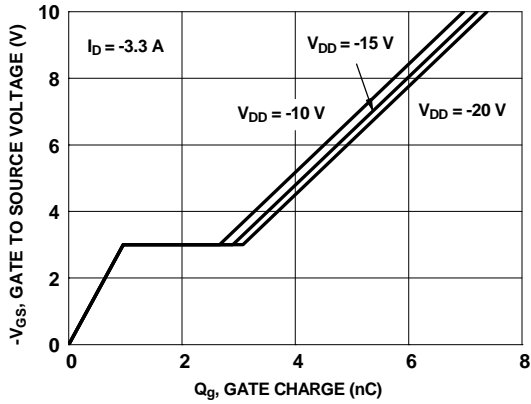


**Figure 5. Transfer Characteristics**

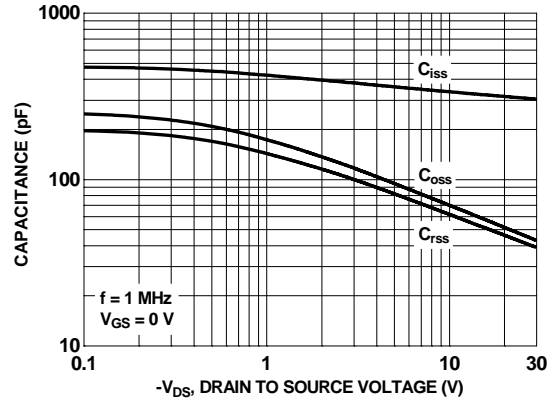


**Figure 6. Source to Drain Diode Forward Voltage vs Source Current**

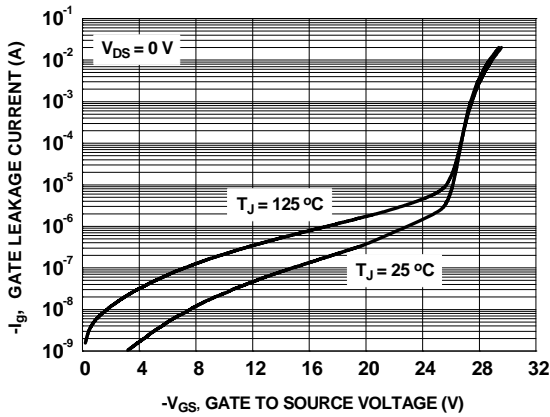
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



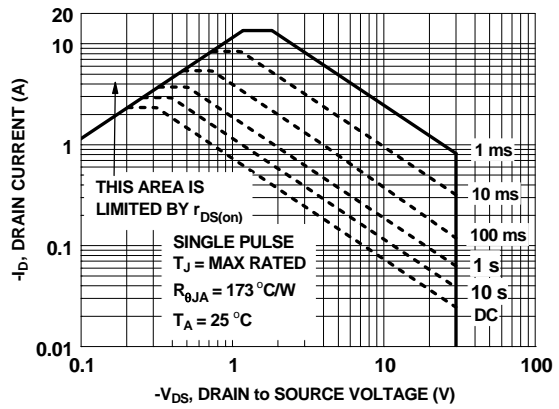
**Figure 7. Gate Charge Characteristics**



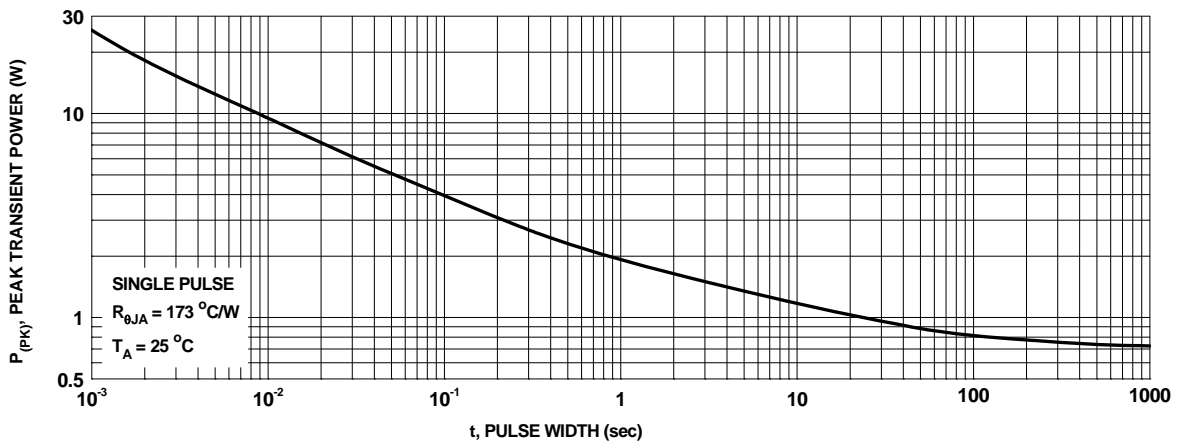
**Figure 8. Capacitance vs Drain to Source Voltage**



**Figure 9. Gate Leakage Current vs Gate to Source Voltage**

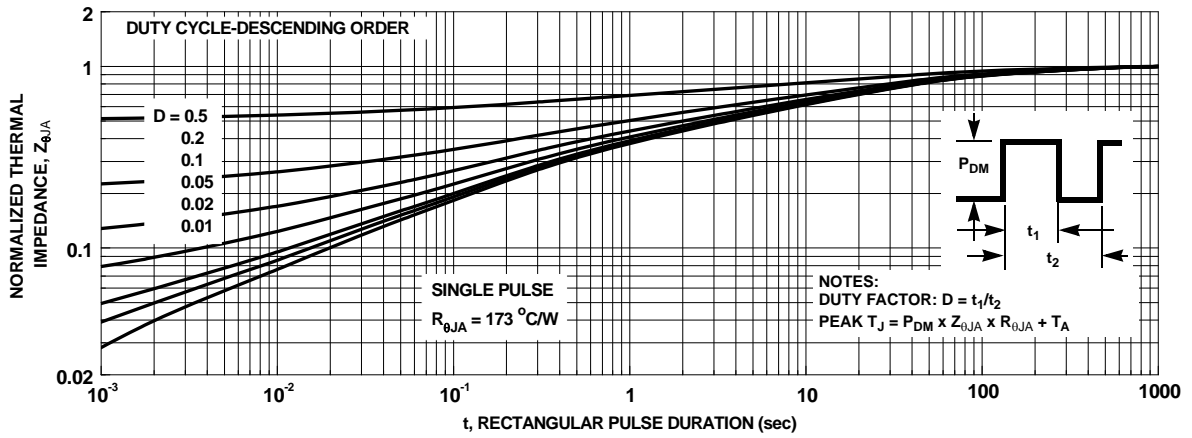


**Figure 10. Forward Bias Safe Operating Area**



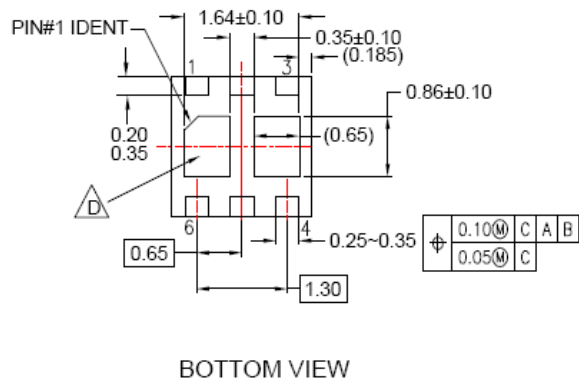
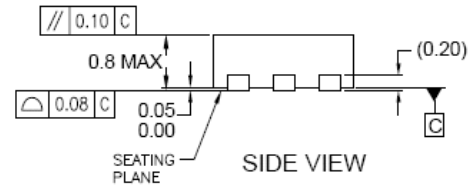
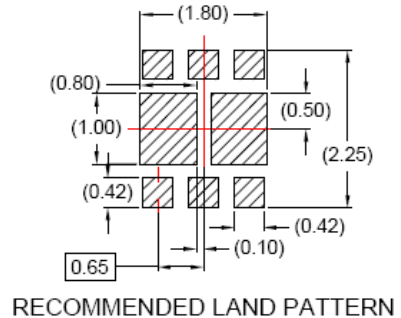
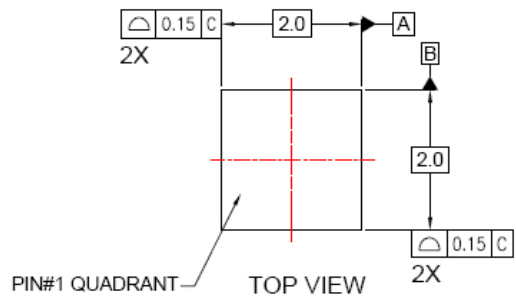
**Figure 11. Single Pulse Maximum Power Dissipation**

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



**Figure 12. Junction-to-Ambient Transient Thermal Response Curve**

### Dimensional Outline and Pad Layout






**NOTES:**

- A. CONFORMS TO JEDEC REGISTRATION MO-229, VARIATION VCC EXCEPT AS NOTED.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- NON-JEDEC DUAL DAP



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No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
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